	- CITALIN ALTO E IN ELI CITALI IN CIT	718 Open D	Date 07/18/07						
-	9-Closed	_ Trend	07-Out Of Tolerance						
-	NCSX	Division	WBS 121						
-	FABRICATION, OPERATIONS & MAINTENANCE								
Item Dwg/Part#	SE124-051 & -054 pts. 15 & 1 Procuremen	t # D-NCS	X-FPA-QA1-00	Cost Center					
RAP# 3250	Job Doc # D-NCSX-FPA-QA1-00 Vend	or							
RAP Title Field Pe	riod Assembly Component Receipt Inspection								
☐ HoldTag Applied									
Nonconforming Condition (include requirement(s) violated):									
VVSA 1, 2, & 3, The hairpin cotter pins for the vacuum vessel vertical support assemblies are above the maximum permeability allowed of 1.02 Mu per NCSX-ASPEC-GRD-04 para. 3.3.1.1.									
Readings obtained we	Upper Support Assembly" part #15 & SE124-05 ere >3.5 Mu but <5.0 Mu on a sample of 8 out proximately 0.15" in dia. by 4.5" long.			r" part #16.					
Lot Size Recd Reported By Ph	20 Sample Size Insp 8 elps C Validated By Box	oscoe J	Lot Rejected Valida	# Rejected 8 ated Date 07/19/07					
Disposition: Reworl	k* Repair* Use As Is* Return To Ve	ndor* Scrap)*						
Please use p. 2 for disposition and approvals.									
For rework or repair	of vendor supplied equipments, fill in inforn	nation below:		Distribution					
#Hours	\$Est Labor	\$G&A		Cog M. Viola					
\$Material	\$Burden	\$Total		Insp Phelps/Boscoe Proj. Doc Control (when closed)					
Disposition By			Date	QC Files					
Supervisor's Cond	cur		Date	Malsbury J Boscoe J					
Eng. Dept. Head C	Concur	I	Date	Edwards J					
WCO/Other			Date	Dudek L Malinowski F					
			-	Williams M					
				Reiersen W					
PQA/QC Mgr Disp	os Concur		Date	Tyrrell M					
QC Field Verificat			Date	_					
	-		Date	-					

Disposition:	Rework	Repair	Use As Is	Return to Vendor	Scrap			
For rework or repair of vendor supplied equipment, fill in information below: # Hours \$ Est Labor \$ G&A								
\$ Mate	erial	\$ Burden		\$ Total				
Disposition b	у							
Supervisor's Concurrence								
Eng. Dept. Head Concurrence								
Other (i.e., WCO/FPE) Concurrence								
PQA/QC Mgr	Disposition Co	oncurrence						
QA Field Veri	fication by							
					p. 2			